Search Notes

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/721,181	ARAKAWA, SHINICHIRO	
Examiner	Art Unit	
Gautam R. Patel	2627	

····	SEARCHED				
Class	Subclass	Date	Examiner		
369	53.19	8/24/2006	GR		
369	44.32	8/23/2006	GR		
	<u></u>				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEAR((INCLUDING SE	CH NOTES ARCH STRATEGY	r)
	DATE	EXMR
EAST/jpo/epo	8/23/2006	gr
Inventor searched	8/23/2006	GR